

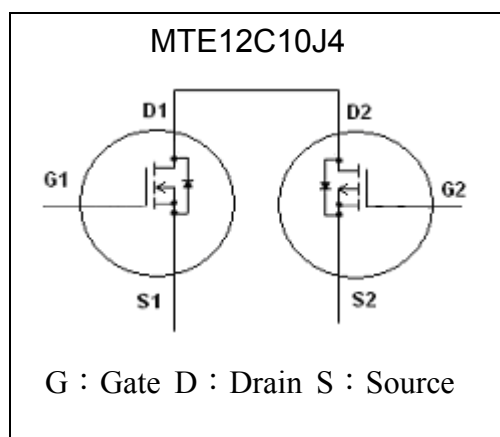
N & P-Channel Enhancement Mode Power MOSFET

Features

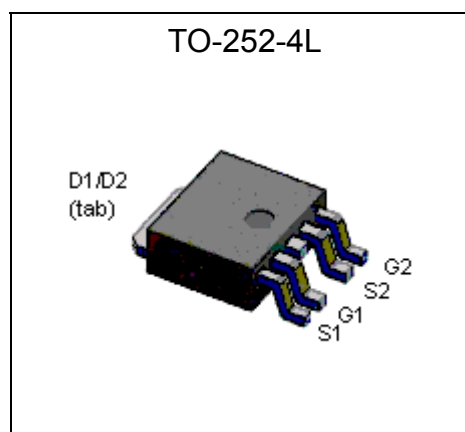
- Low gate charge
- Simple drive requirement
- Pb-free lead plating and halogen-free package

	N-CH	P-CH
BV_{DSS}	100V	-100V
$I_D@V_{GS}=10V(-10V), T_C=25^{\circ}C$	9.3A	-12A
$I_D@V_{GS}=10V(-10V), T_A=25^{\circ}C$	2.0A	-2.5A
$R_{DS(on)(TYP)}@V_{GS}=10V(-10V)$	122m Ω	91m Ω
$R_{DS(on)(TYP)}@V_{GS}=4.5V(-4.5V)$	132m Ω	106m Ω

Equivalent Circuit

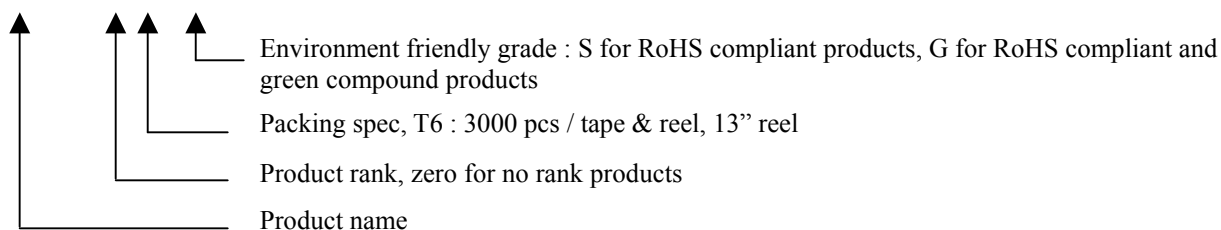


Outline



Ordering Information

Device	Package	Shipping
MTE12C10J4-0-T6-G	TO-252-4L (Pb-free lead plating and halogen-free package)	3000 pcs / Tape & Reel



Absolute Maximum Ratings (T_A=25°C, unless otherwise noted)

Parameter	Symbol	Limits		Unit
		N-channel	P-channel	
Drain-Source Voltage	V _{DS}	100	-100	V
Gate-Source Voltage	V _{GS}	±20	±20	
Continuous Drain Current @ T _C =25°C, V _{GS} =10V(-10V) (Note1)	I _D	9.3	-12.0	A
Continuous Drain Current @ T _C =100°C, V _{GS} =10V(-10V) (Note1)		6.6	-8.5	
Continuous Drain Current @ T _A =25°C, V _{GS} =10V(-10V) (Note2)	I _{DSM}	2.0	-2.5	
Continuous Drain Current @ T _A =70°C, V _{GS} =10V(-10V) (Note2)		1.7	-2.1	
Pulsed Drain Current *1 (Note3)	I _{DM}	20	-20	
Single Pulse Avalanche Current	I _{AS}	9	-30	
Avalanche Energy @ L=0.1mH, I _D =I _{AS} , V _{DD} =50V(-50V)	E _{AS}	4	58	mJ
Total Power Dissipation (T _C =25°C) (Note1)	P _D	37.5		W
Total Power Dissipation (T _C =100°C) (Note1)		18.7		
Total Power Dissipation (T _A =25°C) (Note2)	P _{DSM}	2.4		
Total Power Dissipation (T _A =70°C) (Note2)		1.7		
Operating Junction and Storage Temperature Range	T _j , T _{stg}	-55~+175		°C

Note : *1. Pulse width limited by maximum junction temperature

*2. Duty cycle ≤ 1% 22

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	R _{th,j-c}	4	°C/W
Thermal Resistance, Junction-to-ambient, max (Note2)	R _{th,j-a}	62.5	
Thermal Resistance, Junction-to-ambient, max (Note4)		90	

Note : 1. The power dissipation P_D is based on T_{J(MAX)}=175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

2. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2 oz. copper, in a still air environment with T_A=25°C. The power dissipation P_{DSM} is based on R_{θJA} and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.

3. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175°C. Ratings are based on low frequency and low duty cycles to keep initial T_J=25°C.

4. When mounted on the minimum pad size recommended (PCB mount), t≤10s.

N-CH Characteristics (T_C=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	100	-	-	V	V _{GS} =0V, I _D =250μA
V _{GS(th)}	1.2	-	2.4		V _{DS} =V _{GS} , I _D =250μA
G _{FS} *1	-	5.4	-	S	V _{DS} =10V, I _D =2A
I _{GSS}	-	-	±100	nA	V _{GS} =±20V, V _{DS} =0V
I _{DSS}	-	-	1	μA	V _{DS} =90V, V _{GS} =0V
	-	-	25		V _{DS} =90V, V _{GS} =0V, T _j =125°C
R _{DS(ON)} *1	-	122	160	mΩ	V _{GS} =10V, I _D =2A
	-	132	175		V _{GS} =4.5V, I _D =1.5A

Dynamic					
Qg *1	-	8.0	-	nC	ID=2A, VDS=80V, VGS=10V
Qgs *1	-	1.0	-		
Qgd *1	-	2.3	-		
td(ON) *1	-	5.6	-	ns	VDS=50V, ID=1A, VGS=10V, RG=6Ω
tr *1	-	16.6	-		
td(OFF) *1	-	21.2	-		
tf *1	-	16.4	-		
Ciss	-	281	-	pF	VGS=0V, VDS=25V, f=1MHz
Coss	-	42	-		
Crss	-	21	-		
Source-Drain Diode					
IS *1	-	-	2.0	A	
ISM *2	-	-	8.0		
VSD *1	-	0.80	1.3	V	IS=2A, VGS=0V
trr *1	-	19.5	-	ns	IF=2A, VGS=0V, dIF/dt=100A/μs
Qrr *1	-	17.9	-	nC	

Note : *1.Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

*2.Pulse width limited by maximum junction temperature.

P-CH Characteristics (Tc=25°C, unless otherwise specified)

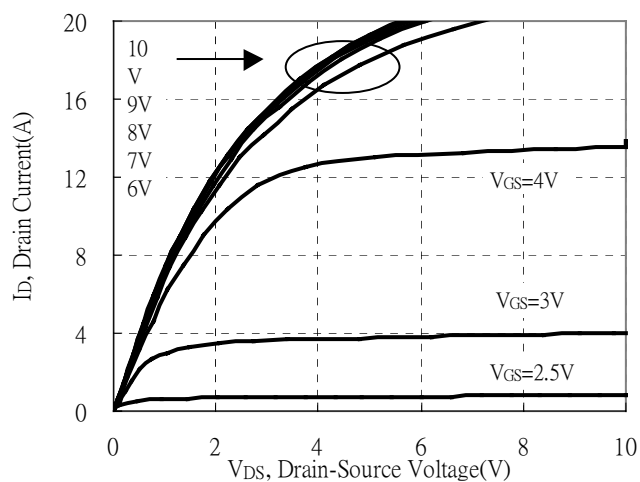
Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	-100	-	-	V	V _{GS} =0V, I _D =-250μA
V _{GS(th)}	-1.2	-	-2.4		V _{DS} =V _{GS} , I _D =-250μA
G _{FS} *1	-	7.1	-	S	V _{DS} =-10V, I _D =-2A
I _{GSS}	-	-	±100	nA	V _{GS} =±20V, V _{DS} =0V
I _{DSS}	-	-	-1	μA	V _{DS} =-80V, V _{GS} =0V
	-	-	-25		V _{DS} =-80V, V _{GS} =0V, T _j =125°C
R _{DS(ON)} *1	-	91	120	mΩ	V _{GS} =-10V, I _D =-2A
	-	106	140		V _{GS} =-4.5V, I _D =-1.5A
Dynamic					
Q _g *1	-	27	-	nC	I _D =-2A, V _{DS} =-80V, V _{GS} =-10V
Q _{gs} *1	-	3.8	-		
Q _{gd} *1	-	6.3	-		
t _{d(ON)} *1	-	10.6	-	ns	V _{DS} =-50V, I _D =-1A, V _{GS} =-10V, R _G =6Ω
tr *1	-	18.4	-		
t _{d(OFF)} *1	-	75.6	-		
t _f *1	-	65.2	-		
C _{iss}	-	1323	-	pF	V _{GS} =0V, V _{DS} =-25V, f=1MHz
C _{oss}	-	116	-		
C _{rss}	-	58	-		
Source-Drain Diode					
I _S *1	-	-	-2.3	A	
I _{SM} *2	-	-	-9.2		
V _{SD} *1	-	-0.75	-1.3	V	I _S =-2.0A, V _{GS} =0V
trr *1	-	22.6	-	ns	I _F =-2.0A, V _{GS} =0V, dI _F /dt=100A/μs
Q _{rr} *1	-	24.8	-	nC	

Note : *1.Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

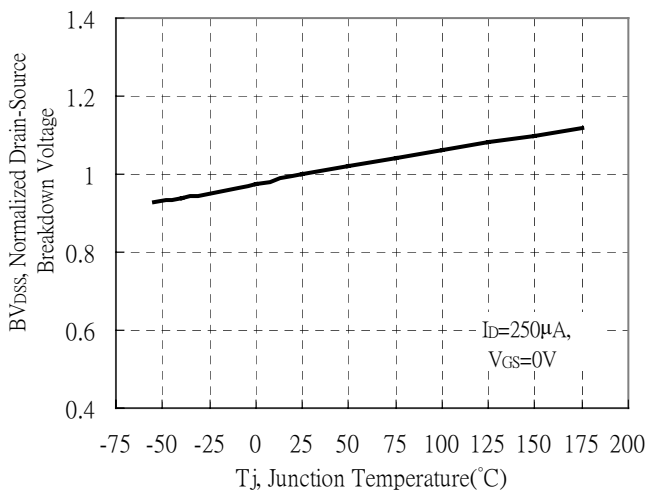
*2.Pulse width limited by maximum junction temperature.

Q1, N-CH Typical Characteristics

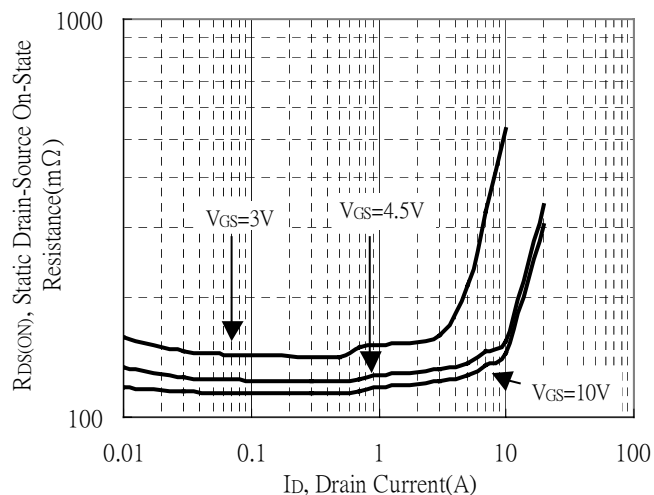
Typical Output Characteristics



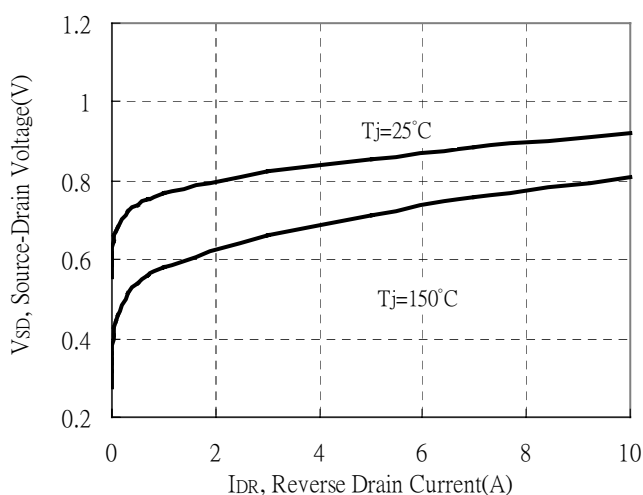
Breakdown Voltage vs Ambient Temperature



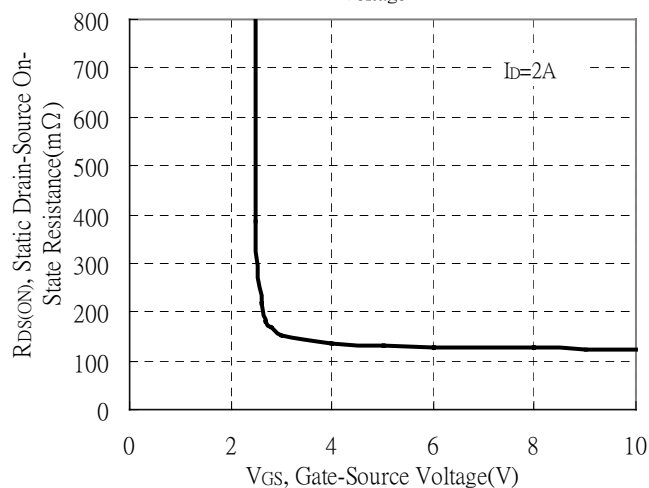
Static Drain-Source On-State resistance vs Drain Current



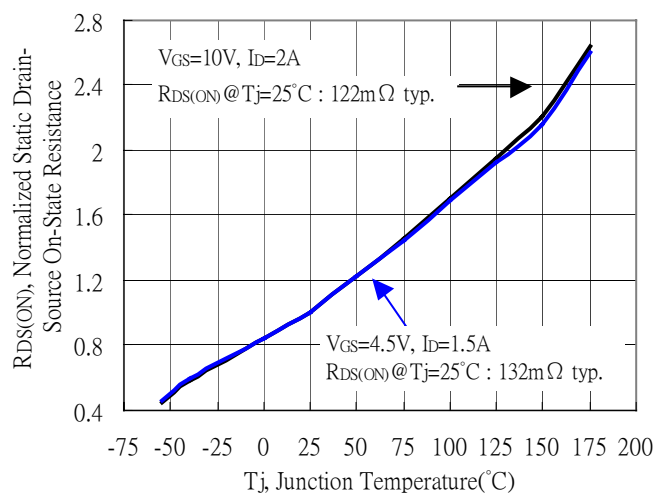
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

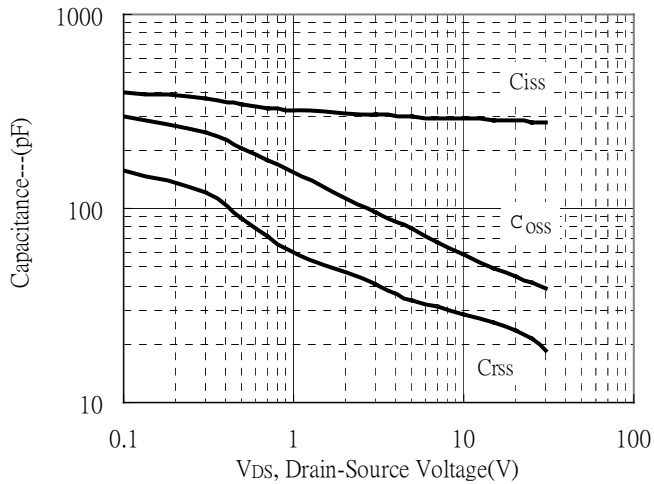


Drain-Source On-State Resistance vs Junction Temperature

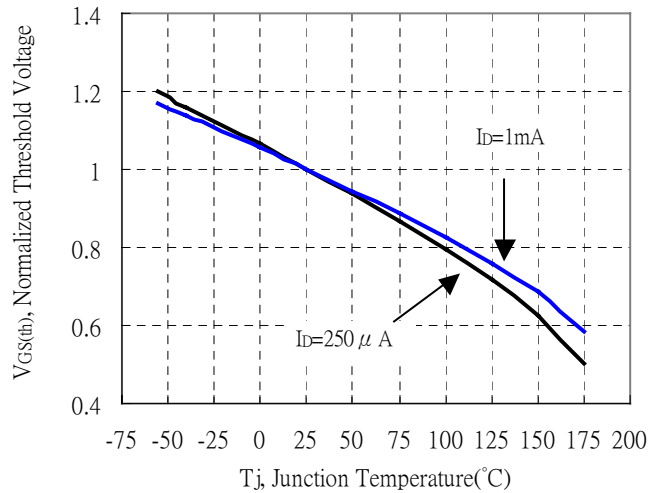


Q1, N-CH Typical Characteristics(Cont.)

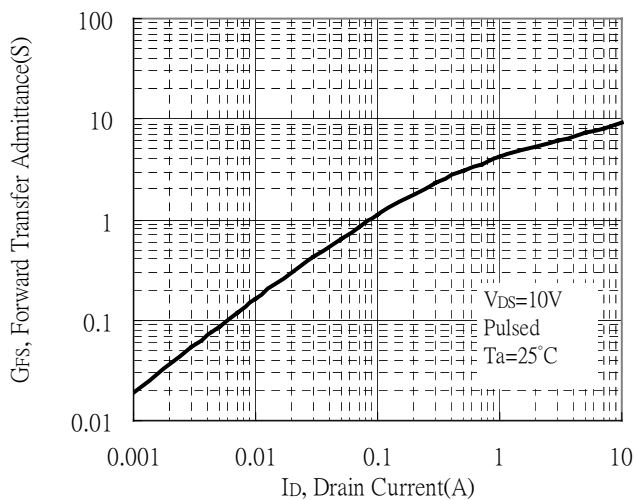
Capacitance vs Drain-to-Source Voltage



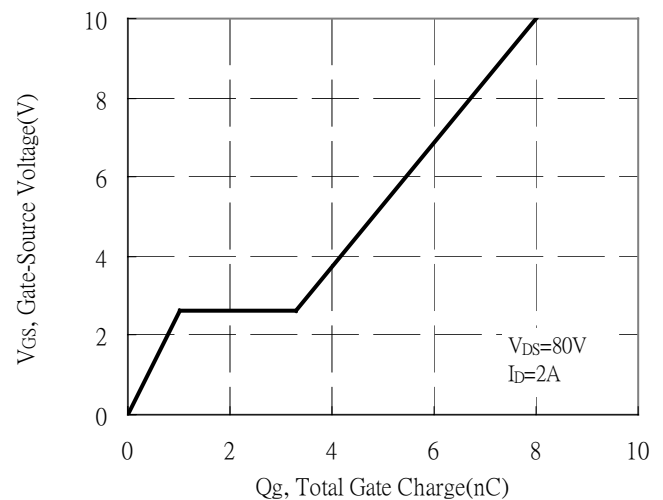
Threshold Voltage vs Junction Temperature



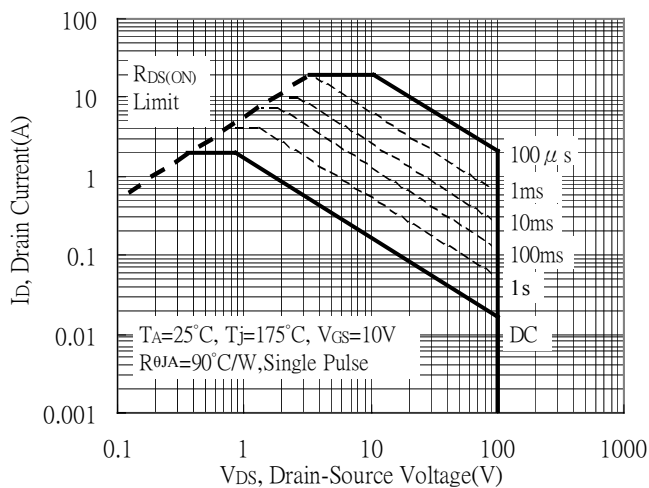
Forward Transfer Admittance vs Drain Current



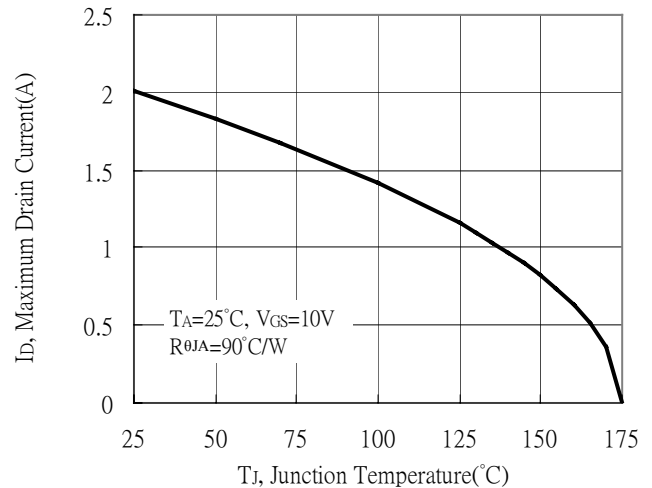
Gate Charge Characteristics



Maximum Safe Operating Area

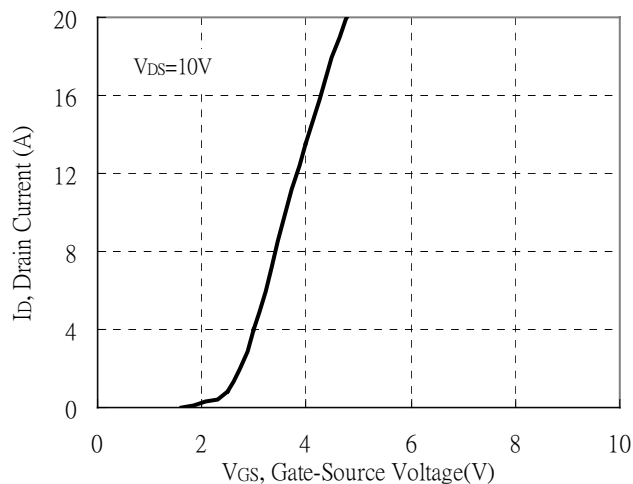


Maximum Drain Current vs Junction Temperature

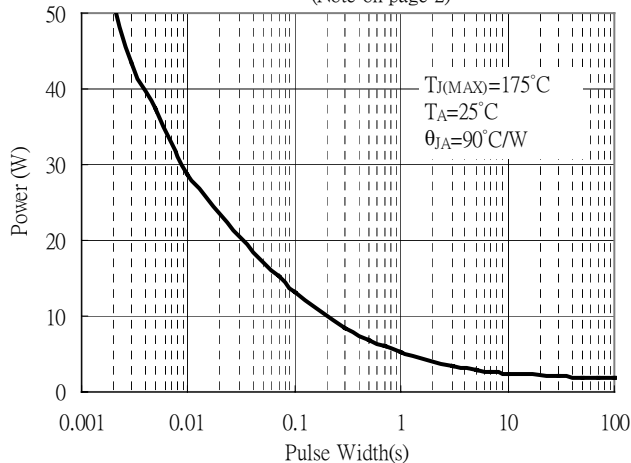


Q1, N-CH Typical Characteristics(Cont.)

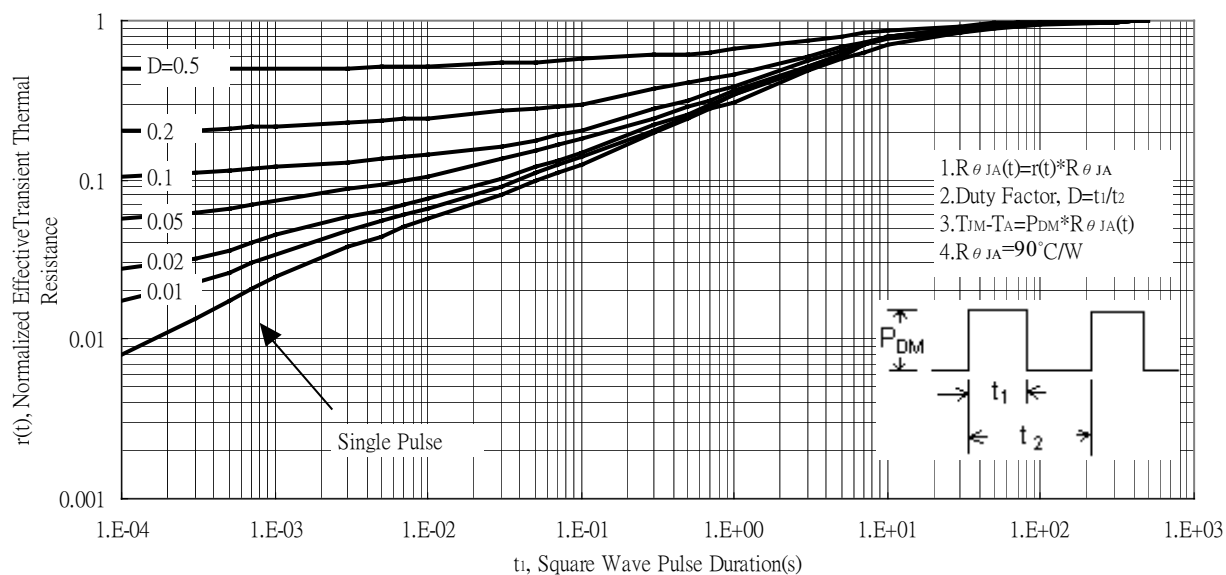
Typical Transfer Characteristics



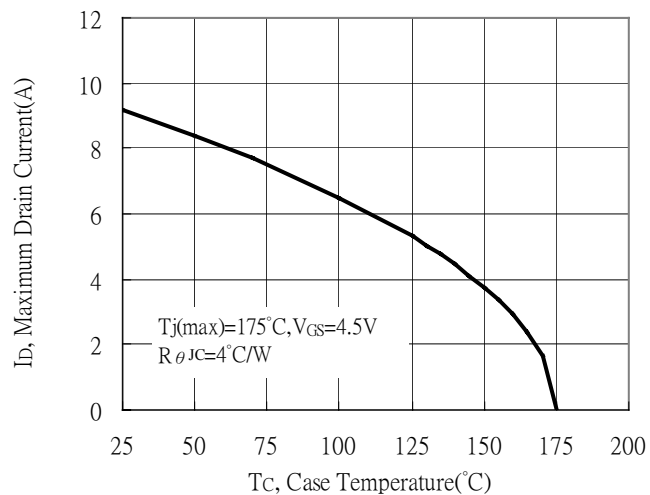
Single Pulse Power Rating, Junction to Ambient
(Note on page 2)



Transient Thermal Response Curves

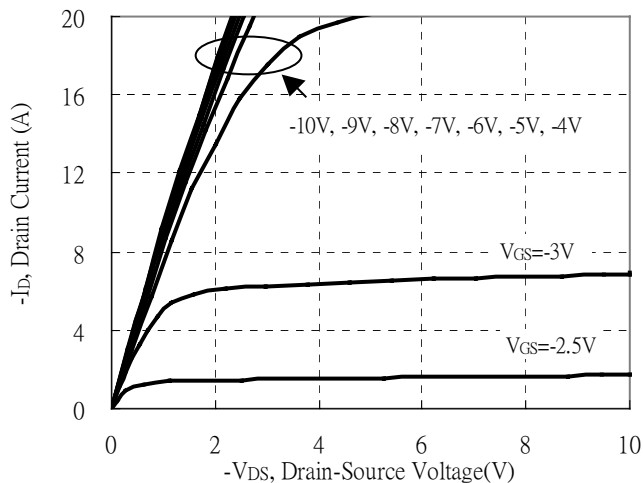


Maximum Drain Current vs Case Temperature

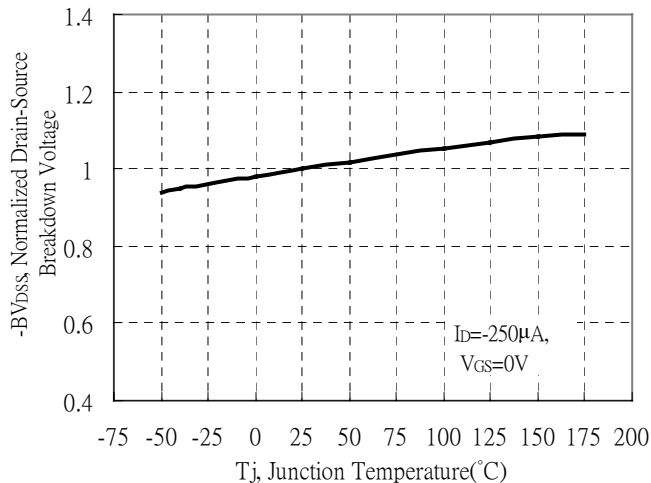


Q2, P-CH Typical Characteristics

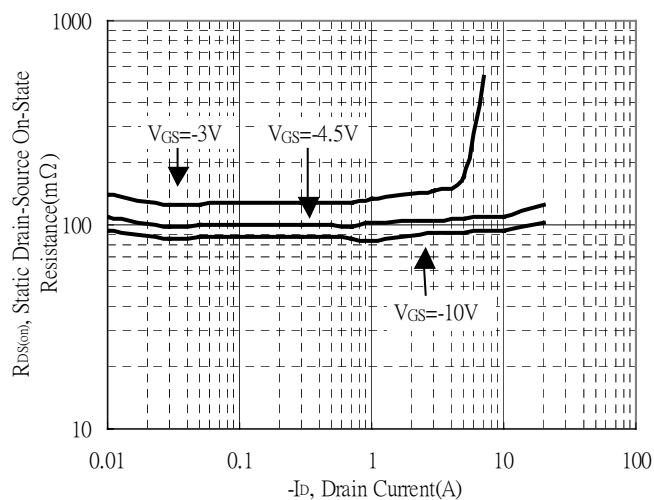
Typical Output Characteristics



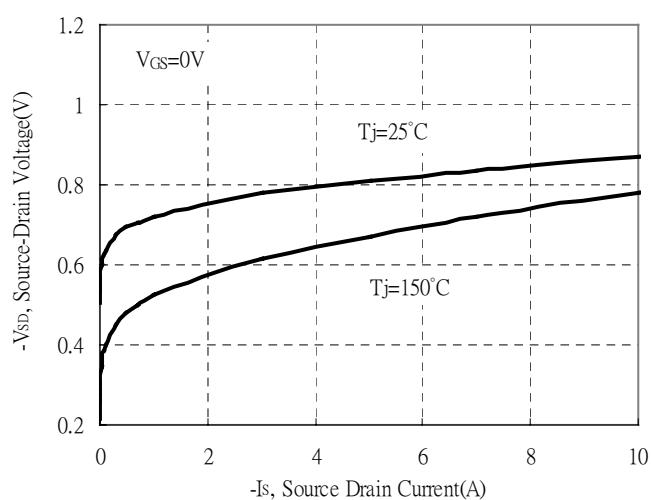
Breakdown Voltage vs Ambient Temperature



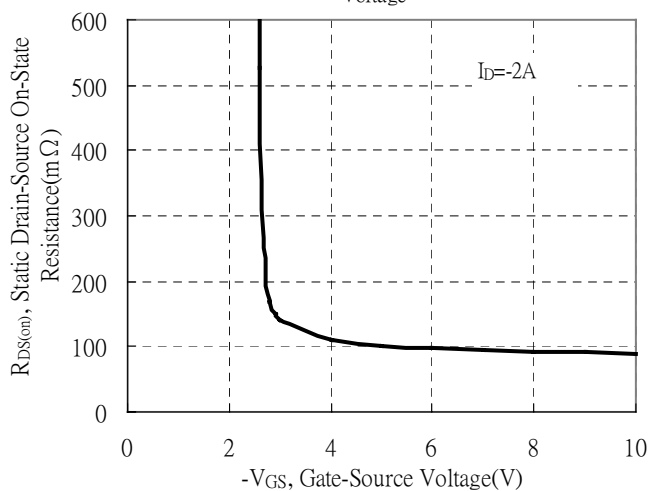
Static Drain-Source On-State resistance vs Drain Current



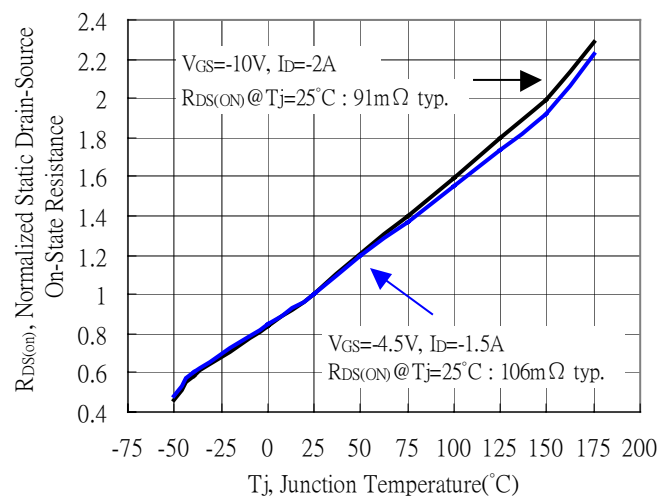
Source Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

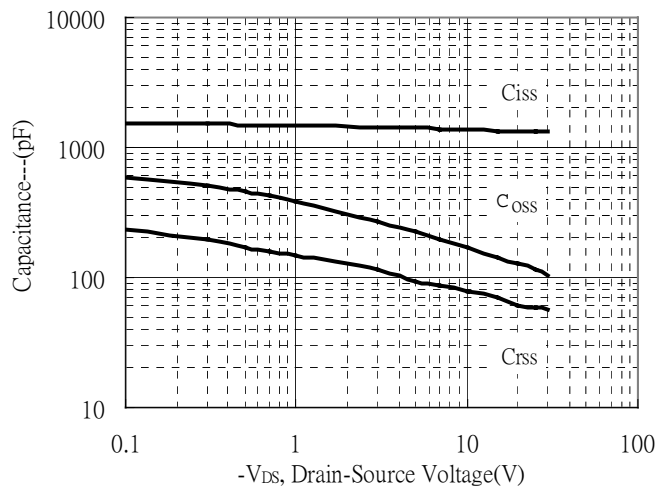


Drain-Source On-State Resistance vs Junction Temperature

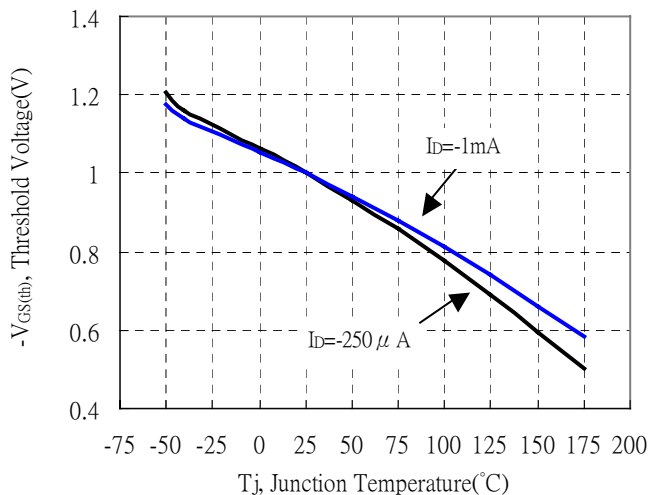


Q2, P-CH Typical Characteristics(Cont.)

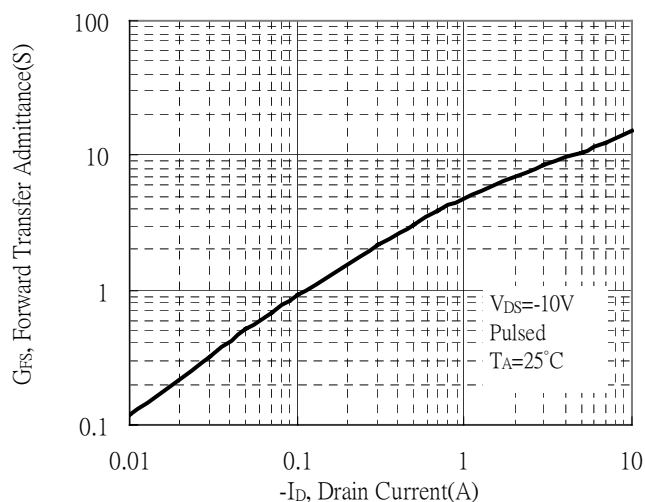
Capacitance vs Drain-to-Source Voltage



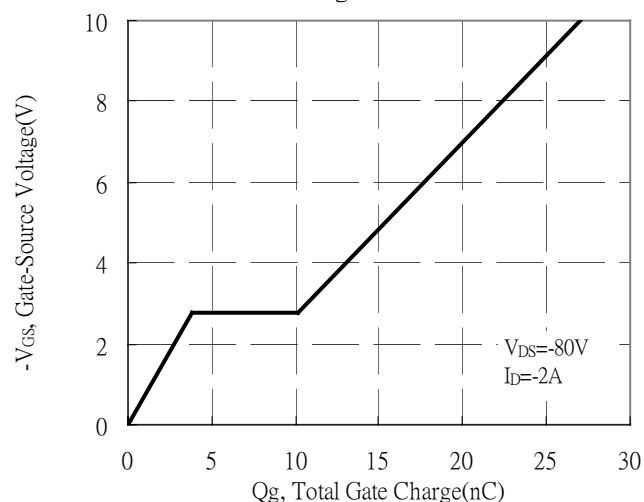
Threshold Voltage vs Junction Temperature



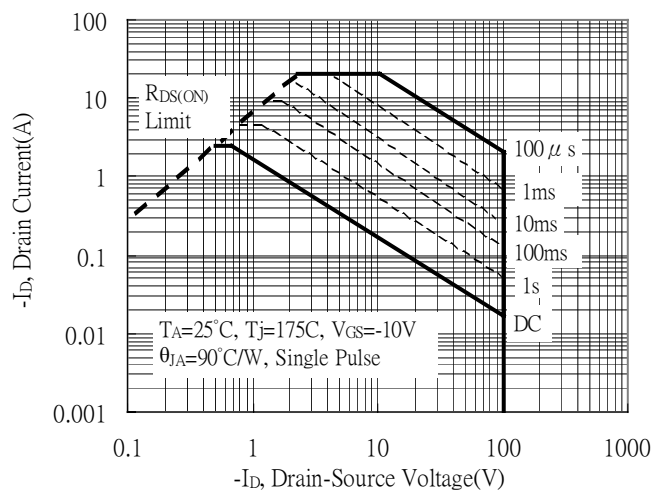
Forward Transfer Admittance vs Drain Current



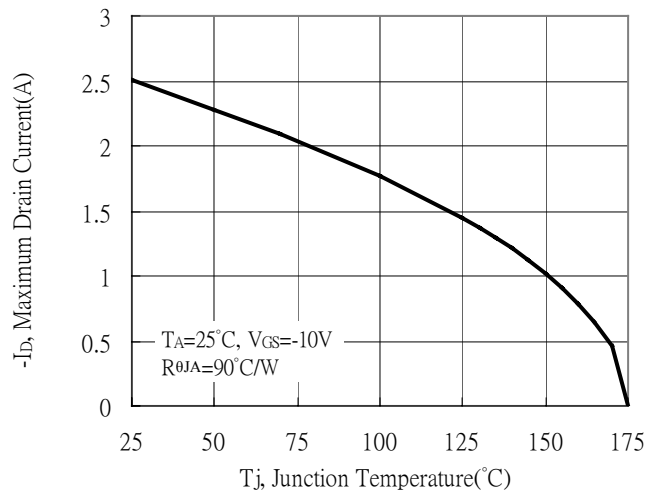
Gate Charge Characteristics



Maximum Safe Operating Area

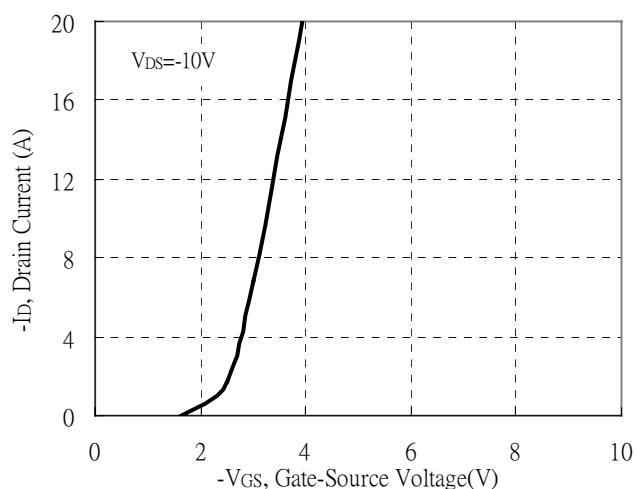


Maximum Drain Current vs Junction Temperature

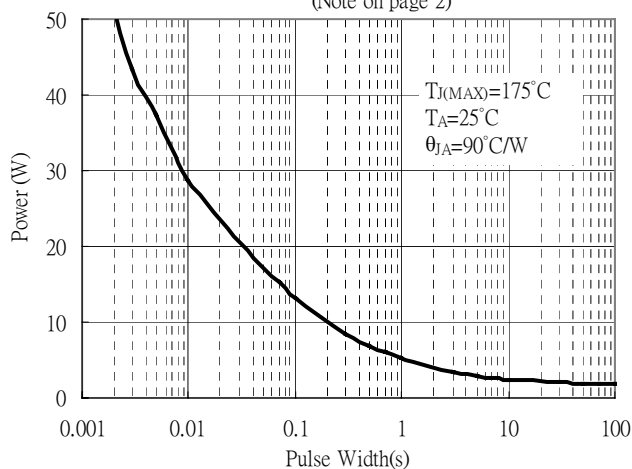


Q2, P-CH Typical Characteristics(Cont.)

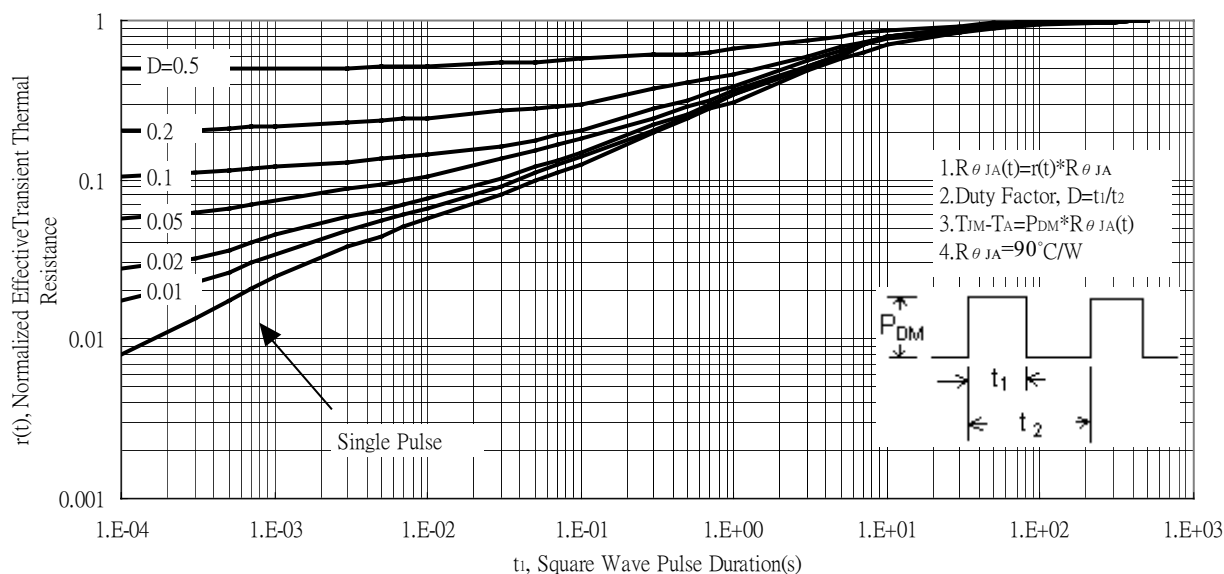
Typical Transfer Characteristics



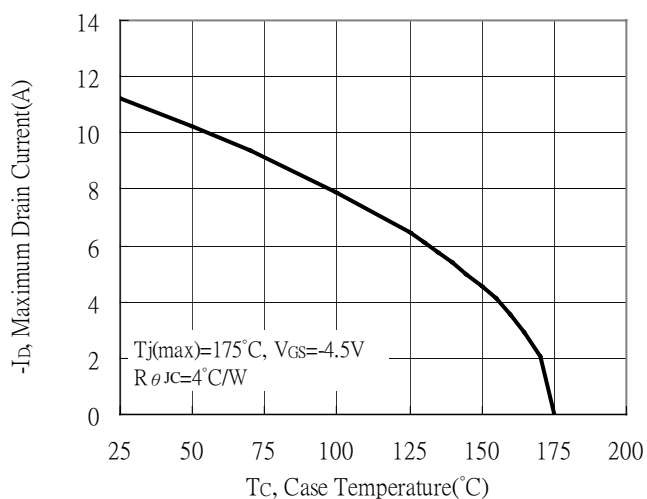
Single Pulse Power Rating, Junction to Ambient
(Note on page 2)



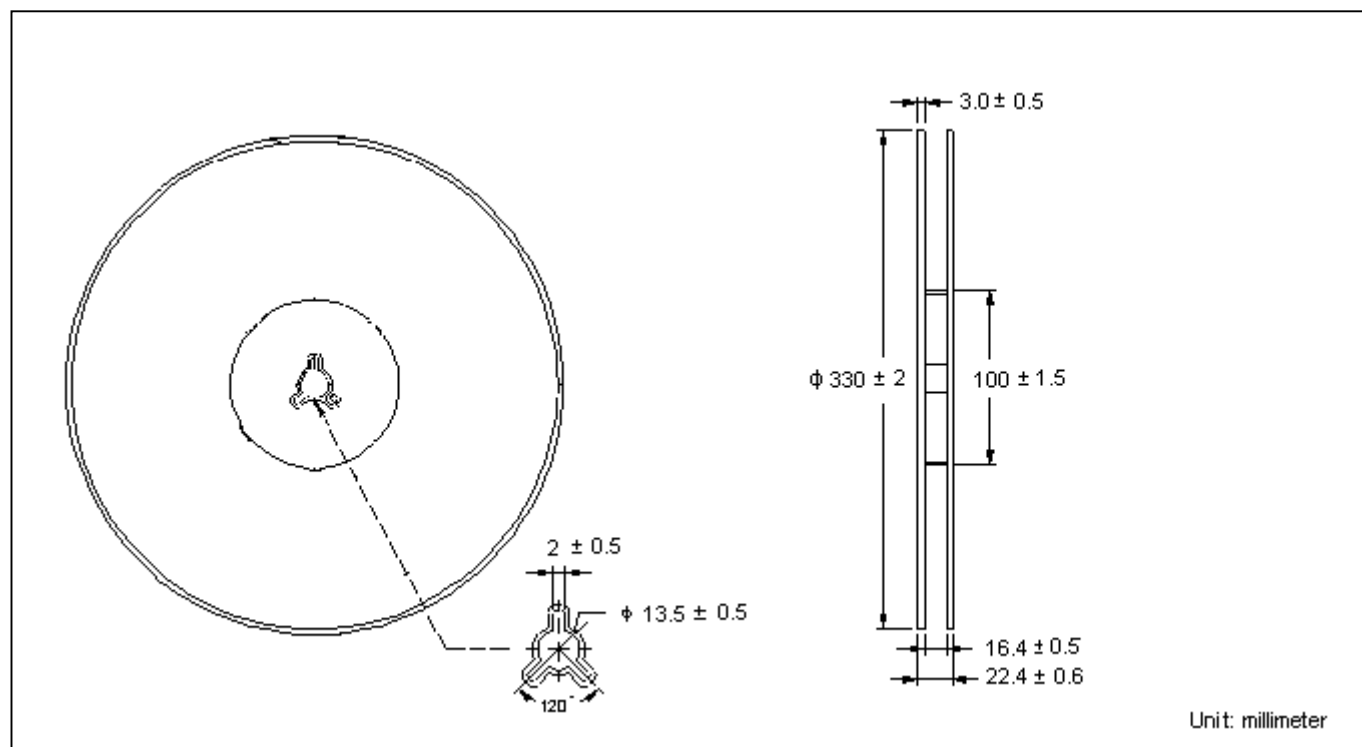
Transient Thermal Response Curves



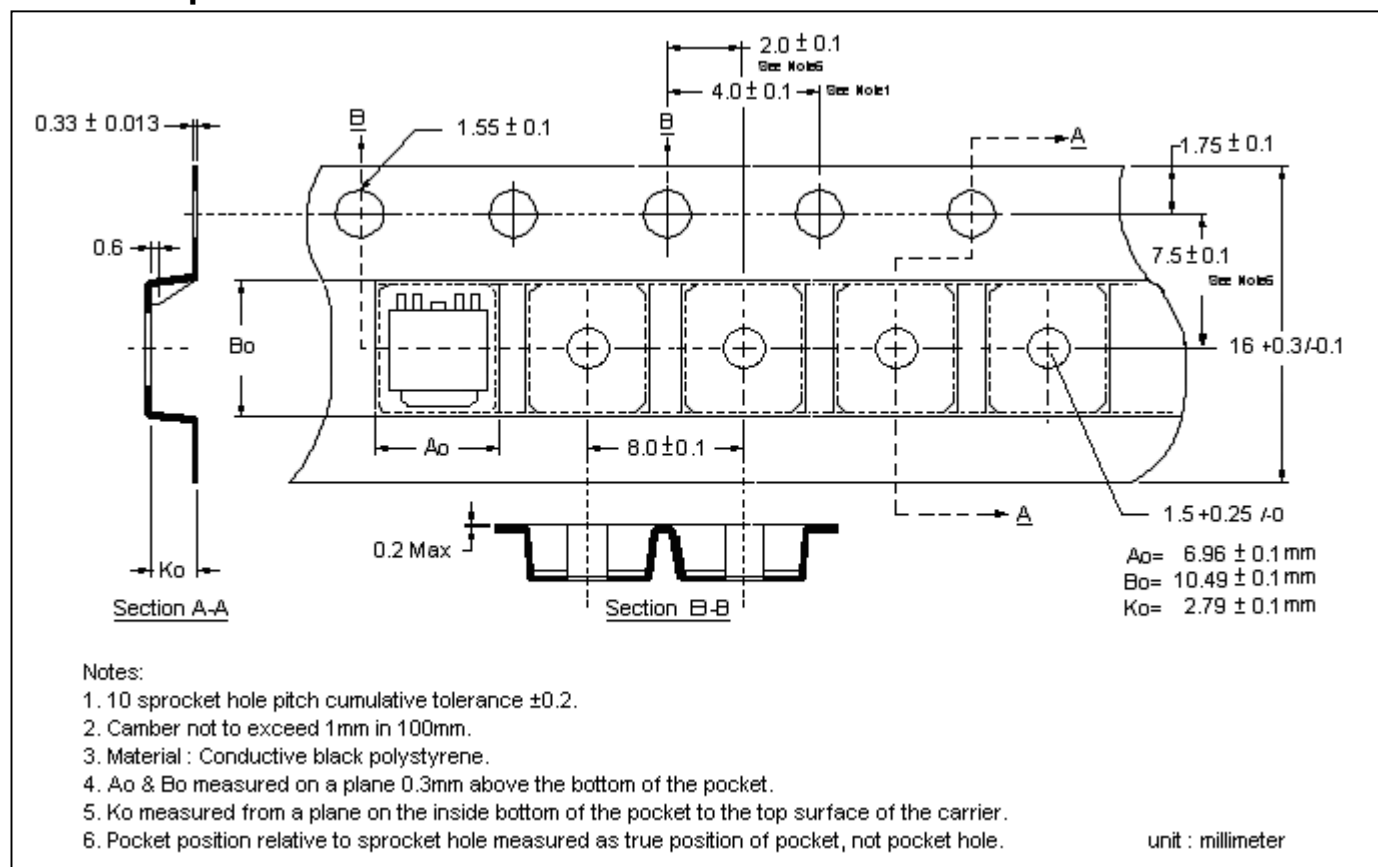
Maximum Drain Current vs Case Temperature

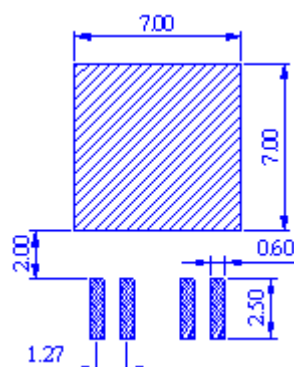


Reel Dimension



Carrier Tape Dimension



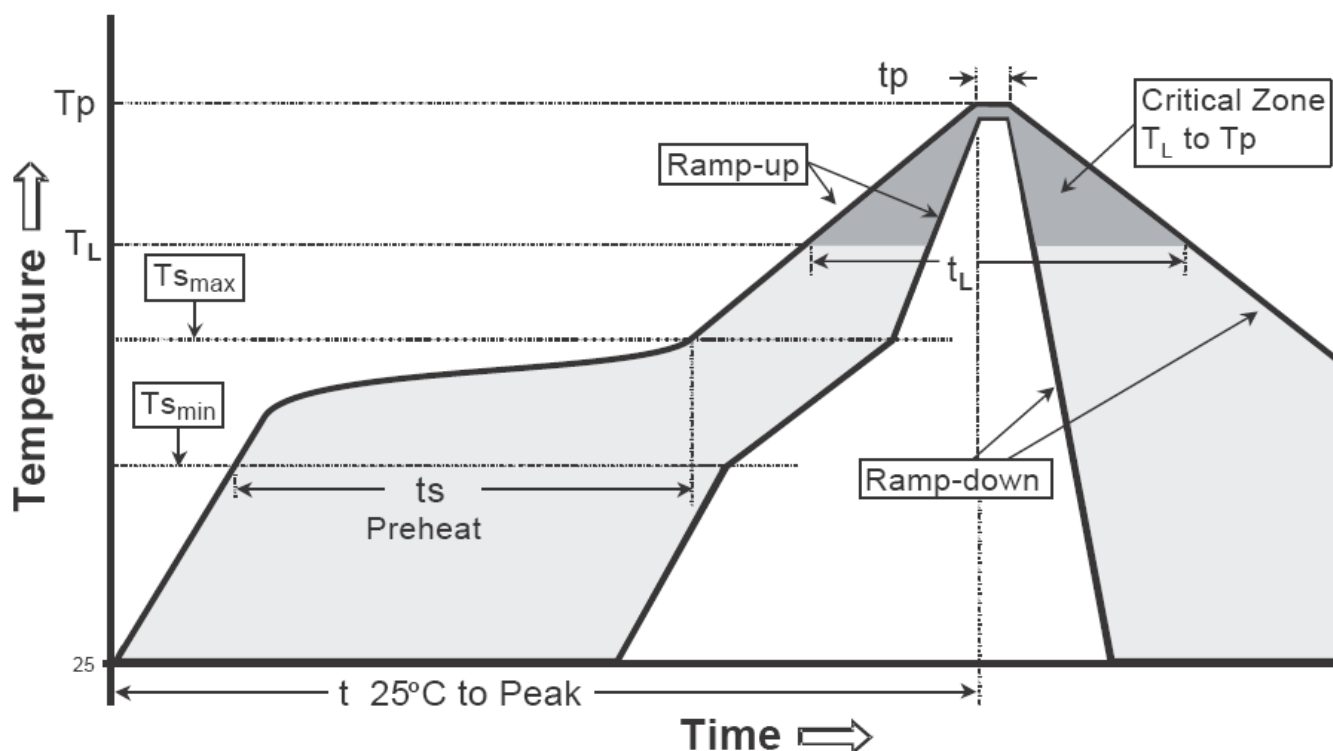
Recommended soldering footprint

Unit : mm

Recommended wave soldering condition

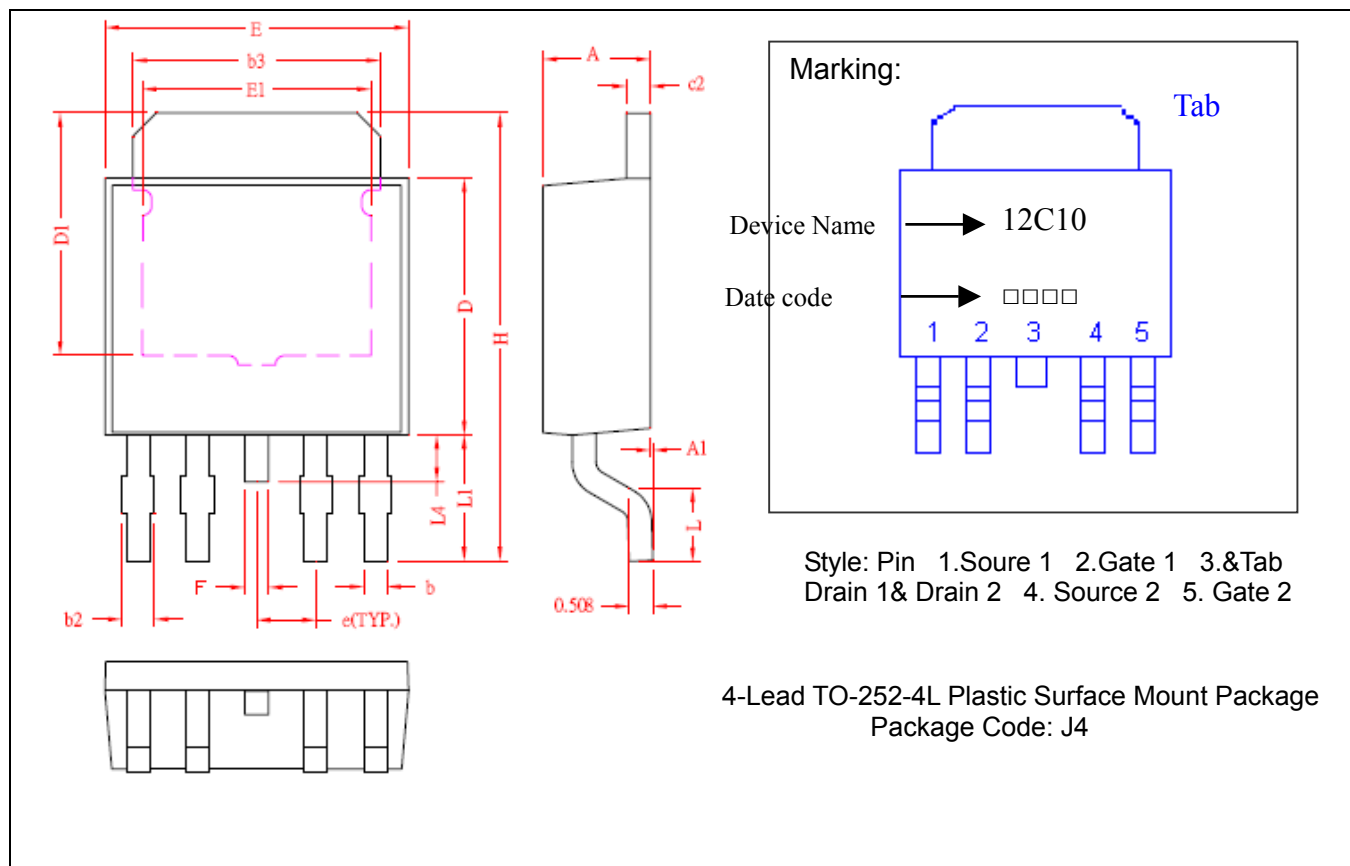
Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (TL)	183°C	217°C
- Time (tL)	60-150 seconds	60-150 seconds
Peak Temperature(TP)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

TO-252-4L Dimension


DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.0866	0.0945	2.20	2.40	E	0.2520	0.2677	6.40	6.80
A1	0.0000	0.0059	0.00	0.15	E1	0.1500	-	3.81	-
b	0.0157	0.0236	0.40	0.60	e	0.0500	REF	1.27	REF
b2	0.0199	0.0315	0.50	0.80	F	0.0157	0.0236	0.40	0.60
b3	0.2047	0.2165	5.20	5.50	H	0.3701	0.4016	9.40	10.20
c2	0.0177	0.0217	0.45	0.55	L	0.0551	0.0697	1.40	1.77
D	0.2126	0.2283	5.40	5.80	L1	0.0945	0.1181	2.40	3.00
D1	0.1799	-	4.57	-	L4	0.0315	0.0472	0.80	1.20

Notes: 1.Controlling dimension: millimeters.

2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.

Material:

- Lead : Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.